TOSHIBA 25K2744

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE ( $\pi$ -MOS V)

# 2 S K 2 7 4 4

HIGH SPEED, HIGH CURRENT SWITCHING APPLICATIONS
CHOPPER REGULATOR, DC-DC CONVERTER AND MOTOR DRIVE
APPLICATIONS

• 4V Gate Drive

• Low Drain-Source ON Resistance :  $R_{DS(ON)} = 24m\Omega$  (Typ.)

• High Forward Transfer Admittance : |Yfs|=27S (Typ.)

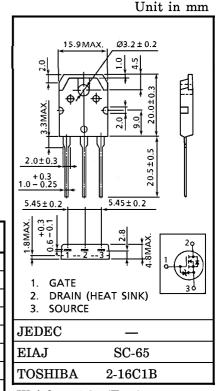
• Low Leakage Current : I<sub>DSS</sub>=100μA (Max.) (V<sub>DS</sub>=50V)

• Enhancement-Mode :  $V_{th} = 1.5 \sim 3.5 \text{V} \text{ (V}_{DS} = 10 \text{V}, I_D = 1 \text{mA)}$ 

#### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERIS	SYMBOL	RATING	UNIT			
Drain-Source Voltage	$V_{ m DSS}$	50	V			
Drain-Gate Voltage (RG	$v_{ m DGR}$	50	V			
Gate-Source Voltage	$v_{GSS}$	±20	V			
Drain Current	DC	$I_{\mathrm{D}}$	45	A		
	Pulse	$I_{\mathrm{DP}}$	180	A		
Drain Power Dissipation	$P_{\mathrm{D}}$	125	W			
Single Pulse Avalanche	EAS	95	mJ			
Avalanche Current	$I_{AR}$	45	A			
Repetitive Avalanche En	EAR	12.5	mJ			
Channel Temperature	$\mathrm{T_{ch}}$	150	°C			
Storage Temperature Ra	$\mathrm{T_{stg}}$	-55~150	°C			

# INDUSTRIAL APPLICATIONS



Weight: 4.6g (Typ.)

# THERMAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel to Case	R <sub>th (ch-c)</sub>	1.0	°C/W
Thermal Resistance, Channel to Ambient	R <sub>th (ch-a)</sub>	50	°C/W

#### Note;

- \* Repetitive rating; Pulse Width Limited by Max. junction temperature.
- \*\*  $V_{DD} = 25V$ , Starting  $T_{ch} = 25^{\circ}C$ ,  $L = 58\mu H$ ,  $R_{G} = 25\Omega$ ,  $I_{AR} = 45A$

This transistor is an electrostatic sensitive device. Please handle with caution.

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## ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARAC	TERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage	Current	IGSS	$V_{GS} = \pm 16V, V_{DS} = 0V$	_	_	±10	$\mu$ A
Drain Cut-off	Current	$I_{ m DSS}$	$V_{DS}=50V, V_{GS}=0V$	_	_	100	$\mu$ A
Drain-Source 1 Voltage	Breakdown	V (BR) DSS	$I_D=10$ mA, $V_{GS}=0$ V	50	-	_	V
Gate Threshol	d Voltage	$V_{ m th}$	$V_{DS}=10V, I_{D}=1mA$	1.5	_	3.5	V
Drain-Source	ON Resistance	R <sub>DS</sub> (ON)	$V_{GS} = 10V, I_D = 25A$	_	15	20	$\mathbf{m}\Omega$
Forward Trans Admittance	sfer	Y <sub>fs</sub>	$V_{ m DS} = 10 V, \; I_{ m D} = 25 A$	15	27	_	S
Input Capacita	ance	$\mathrm{c}_{\mathrm{iss}}$		_	2300	_	
Reverse Transfer Capacitance		C <sub>rss</sub>	$V_{DS} = 10V, V_{GS} = 0V, f = 1MHz$	_	420	_	pF
Output Capaci	Output Capacitance			_	1200	_	
Switching Time Fall Time	Rise Time	$egin{array}{c} { m C}_{ m oss} \ & { m t}_{ m r} \end{array}$	V <sub>GS</sub> <sub>0V</sub>	_	30	_	
	Turn-on Time	t <sub>on</sub>	$^{\text{VGS}}$ $_{0\text{V}}$ $^{\text{L}}$ $^{\text{RL}}$ $^{\text{RL}}$	_	45	_	ns
	Fall Time	$t_f$	4' →	_	80	_	lis
	Turn-off Time	t <sub>off</sub>	$V_{ ext{IN}}: t_{ ext{r}}, t_{ ext{f}}{<}5 ext{ns}, \  ext{Duty} \leq 1\%, t_{ ext{w}}{=}10\mu ext{s}$	_	230	_	
Total Gate Charge (Gate-Source Plus Gate-Drain)		$\mathbf{Q}_{\mathbf{g}}$	V-> -40V Vaa=10V I45A	_	68	_	nC
Gate-Source Charge		$\mathbf{Q}_{\mathbf{g}\mathbf{s}}$	$V_{DD} = 40V, V_{GS} = 10V, I_D = 45A$	_	20	_	
Gate-Drain ("Miller") Charge		$\mathbf{Q}_{\mathbf{gd}}$		_	48	_	

### SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	$I_{ m DR}$	_	_	_	45	A
Pulse Drain Reverse Current	$I_{ m DRP}$	_	_	_	180	A
Diode Forward Voltage	$V_{ m DSF}$	$I_{DR}$ =45A, $V_{GS}$ =0V	_	-	-1.8	V
Reverse Recovery Time	$t_{rr}$	$I_{DR}$ =45A, $V_{GS}$ =0V	_	130	_	ns
Reverse Recovery Charge	$Q_{\mathbf{rr}}$	$ m dI_{DR}$ / $ m dt$ = 50A / $ m \mu s$	_	0.3	_	nC

# MARKING

